



Department: Calibration Laboratory ISO/IEC 17025 Accreditation No. 008 Appendix to Certificate No. 008-06

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Schedule of Accreditation

Item	Scope Type	Site	Measurand Instrument, Gauge	Range [Including margins] (Does not include margins)	CMC Expressed as an Expanded Uncertainty (95%)	Reference Documents	Remarks
Calibration – Electrical Quantities - DC & LF					כיוול – גדלים חשמליים - זרם ישר ותדר נמוך		
1	A	P	AC Current, Measuring Instruments זרם חילופני, מכשירי מדידה	1 mA		Portocal II, Automated Calibration Software, User Manual	Datron – 4808 Standard instrument
2	A	P		300 Hz	340 μ A/A		
3	A	P		1 kHz	300 μ A/A		
4	A	P		5 kHz	300 μ A/A		
5	A	P		10 mA			
6	A	P		300 Hz	300 μ A/A		
7	A	P		1 kHz	300 μ A/A		
8	A	P		5 kHz	300 μ A/A		
9	A	P		100 mA			
10	A	P		300 Hz	300 μ A/A		
11	A	P		1 kHz	300 μ A/A		
12	A	P		5 kHz	300 μ A/A		
			1 A				
			300 Hz	450 μ A/A			
			1 kHz	450 μ A/A			
			5 kHz	680 μ A/A			

Site: P or T or M, P-Permanent, T-Temporary, M-Mobile

Type of Scopes: A- Fixed, C- Flexible

Flexible scope in analytical tests: Type of matrix, analytes, experimental systems and/or analytical characteristics may be subject to changes, in accordance with the laboratory's approved and documented procedures. For details, please refer to the list of Accredited Tests, available from the laboratory upon request.



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13	A	P		10 A			
14	A	P		300 Hz	510 μ A/A		
15	A	P		1 kHz	510 μ A/A		
				5 kHz	960 μ A/A		
16	A	P	AC Voltage, Measuring Instruments	מתח חילופין, מכשירי מדידה	100 mV	Portocal II Automated Calibration Software, User manual	Datron – 4808 Standard instrument
17	A	P		1 kHz	180 μ V/V		
18	A	P		10 kHz	180 μ V/V		
19	A	P		30 kHz	190 μ V/V		
20	A	P		100 kHz	470 μ V/V		
				1 MHz	3.4 mV/V		
21	A	P		1 V			
				10 Hz	160 μ V/V		
22	A	P		300 Hz	150 μ V/V		
23	A	P		1 kHz	68 μ V/V		
24	A	P		10 kHz	150 μ V/V		
25	A	P		30 kHz	240 μ V/V		
26	A	P		100 kHz	370 μ V/V		

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Calibration – Electrical Quantities - DC & LF					כיוול – גדלים חשמליים - זרם ישר ותדר נמוך		
42	A	P		100 kHz 1 kV	1.3 mV/V		
43	A	P		1 kHz	150 μV/V		
44	A	P		10 kHz	210 μV/V		
45	A	P		30 kHz	210 μV/V		
46	A	P	DC Current, Measuring Instruments	100 μA	130 μA/A		
47	A	P		1 mA	53 μA/A		
48	A	P		10 mA	53 μA/A		
49	A	P		100 mA	52 μA/A		
50	A	P		1 A	130 μA/A		
51	A	P		10 A	180 μA/A		
52	A	P	DC Resistance, Measuring Instruments	10 Ω	27 μΩ/Ω		4 wire connection
53	A	P		100 Ω	13 μΩ/Ω		
54	A	P		1 kΩ	13 μΩ/Ω		
55	A	P		10 kΩ	21 μΩ/Ω		
56	A	P		100 kΩ	14 μΩ/Ω		

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Calibration – Electrical Quantities - DC & LF						כיוול – גדלים חשמליים - זרם ישר ותדר נמוך		
57	A	P			1 MΩ	39 μΩ/Ω		
58	A	P			10 MΩ	86 μΩ/Ω		
59	A	P	DC Voltage, Measuring Instruments	מתח בורם ישר, מכשירי מדידה	100 mV	12 μV/V	Portocal II, Automated Calibration Software User Manual	Datron – 4808 Standard instrument
60	A	P			1 V	6 μV/V		
61	A	P			10 V	4 μV/V		
62	A	P			100 V	7 μV/V		
63	A	P			1 kV	9 μV/V		

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Calibration – Electrical Quantities – HF Electrical Power and Energy					כיוול – גדלים חשמליים - הספק ואנרגיה חשמלית בתדר גבוה		
64	A	P	RF Power Sensor	10 MHz	1.5 %	Weinschel System II, User Manual	For N type connectors The power sensors are calibrated at 1 mW. The uncertainties are expressed as percentage of Calibration factor value. CMC value stands for termistor calibrations. Other sensors may be calibrated at larger uncertainty values.
65	A	P	Calibration Factor, Measuring Instruments	30 MHz	1.1 %		
66	A	P		50 MHz	reference		
67	A	P		100 MHz	1.1 %		
68	A	P		200 MHz	1.2 %		
69	A	P		300 MHz	1.1 %		
70	A	P		400 MHz	1.3 %		
71	A	P		500 MHz	1.3 %		
72	A	P		1 GHz	1.3 %		
73	A	P		2 GHz	1.2 %		
74	A	P		3 GHz	1.4 %		
75	A	P		4 GHz	1.6 %		
76	A	P		5 GHz	1.9 %		
77	A	P		6 GHz	1.8 %		
78	A	P		7 GHz	1.5 %		
79	A	P		8 GHz	1.5 %		

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80	A	P		9 GHz	1.8 %		
81	A	P		10 GHz	1.8 %		
82	A	P		11 GHz	1.7 %		
83	A	P		12 GHz	1.5 %		
84	A	P		13 GHz	1.6 %		
85	A	P		14 GHz	1.8 %		
86	A	P		15 GHz	1.6 %		
87	A	P		16 GHz	1.6 %		
88	A	P		17 GHz	2.0 %		
89	A	P		18 GHz	2.5 %		

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Calibration – Electrical Quantities – HF Electrical Power and Energy					כיוול – גדלים חשמליים - הספק ואנרגיה חשמלית בתדר גבוה		
90	A	P	RF Power Sensor	0.05 GHz	reference		For 2.4 mm connectors
91	A	P	Calibration Factor, Measuring Instruments	0.1 GHz	1.8 %		Using HP 8487A Standard instrument
92	A	P		0.5 GHz	1.8 %		The power sensors are calibrated at nominal 0.5 mW.
93	A	P		1 GHz	1.8 %		The uncertainties are expressed as percentage of Calibration factor.
94	A	P		2 GHz	1.8 %		
95	A	P		10 GHz	1.9 %		The calibration method and software are developed by the Elisra Electronic System Metrology Laboratory
96	A	P		14 GHz	2.0 %		
97	A	P		18 GHz	2.1 %		
98	A	P		20 GHz	2.1 %		
99	A	P		22 GHz	2.1 %		
100	A	P		24 GHz	2.2 %		
101	A	P		26 GHz	2.3 %		
102	A	P		28 GHz	2.5 %		
103	A	P		30 GHz	2.5 %		
104	A	P		32 GHz	2.8 %		
105	A	P		34 GHz	2.5 %		

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Calibration – Electrical Quantities – HF Electrical Power and Energy					כיוול – גדלים חשמליים - הספק ואנרגיה חשמלית בתדר גבוה		
106	A	P		36 GHz	2.8 %		
107	A	P		38 GHz	3.1 %		
108	A	P		40 GHz	3.2 %		
109	A	P	RF Power, Sources	הספק תדר גבוה 50 MHz	1.0 %	Weinschel System II, User Manual	Reference Source 1 mW

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Calibration – Electrical Quantities - RF Frequency, Time					כיוול – גדלים חשמליים - תדר גבוה, זמן		
110	A	P	Frequency, Measuring Instruments	תדר, מכשירי מדידה 10 MHz	1×10^{-11} Hz	Datum – 9390, User Manual	Using Datum GPS Frequency Generator 26 h Integration time
111	A	P	Frequency, Sources	תדר, מחוללים 10 MHz to 40 GHz	1×10^{-10} Hz	Datum – 9390, User Manual	Using Frequency Generator HP 83640A Standard instrument 10 sec. Integration time

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